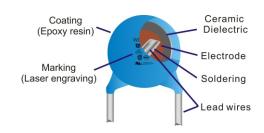


- Complies with IEC60384-14
- Single Layer AC Disc Safety Capacitor
- Coated with flame-retardant epoxy resin (conforming to UL94V-0)
- Lead with tin plated copper wire, inert metal copper or silver as a coating after the electrode, see diagram
- Halogen-free available



RECOGNITIONS : made for RFE by UL/VDE/CQC shop Welson

Approved	Country	Standards	Rated	/oltage	Certification Number		
monogram	Country	Standards	KL (X1Y2)	WD (X1Y1)	KL (X1Y2)	WD (X1Y1)	
c 🔁 us	USA	UL 60384-14	X1 : 500Vac	X1 : 760Vac	E104	1570	
	Canada	OE 00384-14	Y2 : 500Vac	Y1 : 500Vac	E104	+572	
	Germany	EN60384-14 (0565-1-1) : 2014-04 EN60384-14: 2013-08 IEC 60384-14 ed. 4	X1 : 440Vac X1 : 660Vac Y2 : 300Vac Y1 : 500Vac		40016156	4016157	
<u>M</u>	Korea	KC60384-14 / KC60384-1	250	250Vac		SZ03004-17001	
CeC	China	GB/T 6346.14-2015	X1 : 400Vac X1 : 400Vac Y2 : 250Vac Y1 : 250Vac		CQC03001008380	CQC03001008379	

ELECTRICAL CHARACTERISTICS

Characteristics	للهو óو ð∐ ¥[شو ó و à İ 5 İ				
Capacitance range	5uFو ¢∱∌ Cُ C	1pF to 0.01uF				
Rated voltage	X1: 500 Vac Y2: 500 Vac	X1: 760 Vac Y1: 500 Vac				
Dielectric strength	2500Vac (50Hz-60Hz, 50mA max.) for 1 minute.	4000Vac (50Hz-60Hz, 50mA max.) for 1 minute.				
Capacitance	Within the specified tolerance. Y5P, Y5U, Y5V, X7R measured at 1KHz±20% C0G, SL measured at 1MHz±20% Both are 1Vrms, 25°C					
Dissipation Factor (tanδ) or Q Value	SL and COG:Y5P, Y5P $Q \ge 400+20C_R (C_R < 30pF)$ tan δ : $Q \ge 1000 (C_R \ge 30pF)$ Measured condition see "Capacitance"	U, X7R: Y5V: 0.025 max. tan δ: 0.050 max.				
Insulation resistance	10,000M Ω minimum at 500VDC for 1 minu	ite.				
Operating temperature	-55°C to 125°C					



CAPACITANCE CHART

Class			X1 Y2	(KL type)					X1 Y1	l (WD ty	pe)		
Dielectric	C0G (C)	SL (L)	Y5P (B)	X7R (X)	Y:	5U E)	Y5V (F)	C0G (C)	SL (L)	Y5P (B)	X (7R X)	Y5U (E)	Y5V (F)
Capacitance 1.0 (pF) 1.5	G G	G G	GG					GG	G G	GG				
2.2 3.3	G	G G	G G					G G	G G	G				
4.7 5.1	GG	G G	GG	G				J J	J	1		1		
6.8 10	L J	J G		G			-	K	K G	J		J		
12 15		G G		G					G G	J		J		
18 20		GG		G					G	J		J		
22 27	+	GJ		G					G	J		J K		
30 33		J		G					G	J K		K K		
36 39 47		L J J		GGG					G G L	K K K		K K		
56		ĸĸ	ĸĸ	GG					L	K		K K		
82 100		ĸ	K G	G					ī	K K		ĸ	G	
120 150			G	GG						ĸ		ĸ	GG	
180 220			G G	GG						ĸ		K K	G G	
270			G	G		E				K		K K	G G	
390 470			J J	1		E	E			K		K K	G G	G
560 680			J				E			K K		K L	G	G
820 860			J	J		E E	E			L		L L	1	G
1000 1200			L	J		3	G G			N N		N N		G G
1500 1800 2000			N N O	М						O R R		O R R	K K L	l J J
2200 2200 2700	1		0			J	1			R		R	L	JK
2800							J						L	K L
3200 3300							1 J						M	L
3600 3900						VI VI	к к		D				0	M
4000 4700						N N	K L	- (KL 103M		- 1		Q	M
5000 5500					1	N N	L L	_ >	X1 400/ 500V- Y2 250/ 300V-				QQ	N N
5600 6000					(0	L M		→	Φd			QS	N N
6800 8000					1	2	M N		F	-1	10		S S	Q
8200 8600					:	R S	N N						S S	Q R
9000 10000 15000					1	S J	0 0 Q						T U	R R
Lead Spacing (F) (±1.0mm)		1	5.0 &	7.5 & 10.0		•	u			7	.5 & 10.0			
Thickness (T)			6	.0mm							6.0mm			
max. Capacitance Tolerance			Below 10	pF: ±0.25p	oF or ±0.50	9pF; 1	0pF~100p	F: ±5% or ±	±10%; (Over 100p	F: ±10% d	or ±20%		
Coating						Ej	poxy resir	n (UL94V-0)	e e e e e e e e e e e e e e e e e e e					
Body Color							Blu	Je						
Code	E	G	1	J	к	L	м	N	0	Q	R	S	т	U
Diameter (D) max.	7mm	8mm	9mm	10mm	11mm	12mm	14mm	15mm	16mm	19mm	20mm	22mm	25mm	28mm

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$\underline{5} - \underbrace{\text{KL}}_{(1)} \underbrace{\text{F}}_{(2)} \underbrace{472}_{(3)} \underbrace{\text{M}}_{(4)} \underbrace{\text{AC2K5}}_{(5)} \underbrace{10}_{(6)} \underbrace{\text{Y}}_{(7)} \underbrace{5}_{(8)}$

1. Type Code: KL class X1-Y2 ; WD class X1-Y1

2. Temperature Characteristic:

Code	Temp. Coefficient	' Code '		Code	Temp. Coefficient
С	C0G	В	Y5P	E	Y5U
S	SL	Х	X7R	F	Y5V

3. Capacitance Code:

HOW TO ORDER

Expressed by three-digit alphanumeric. The unit is pico-farad (pF). The first and second figures are significant digits, and the third figure expresses the number of zeros which follow the two numbers. If there is a decimal point in between first two figures, it is expressed by the capital letter "R". See below examples:

Code	Capacitance	Code	Capacitance	Code	Capacitance
5R1	5.1 pF	100	10 pF	472	4700 pF
8R0	8 pF	101	100 pF	103	0.1 uF

4. Capacitance Tolerance Code

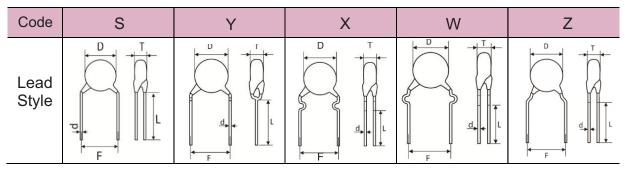
Code	Tolerance	Code	Tolerance	Code	Tolerance
С	± 0.25pF	J	± 5%	М	± 20%
D	± 0.50pF	K	± 10%	Z	+80/-20%

5. Minimum Test Voltage (AC): X1Y2 = AC2K5, X1Y1 = AC4KV

6. Lead Spacing (F)

Code	Lead spacing (F)	Code	Lead spacing (F)
5	5.0±0.8mm	7	7.5±0.8mm
6	6.35±0.8mm	10	10.0±0.8mm

7. Lead style



8. Lead length & package style:

Omitted for un-cut bulk pack or Code L

5 = 5 + -1mm, bulk pack, 6 = 6 + -1mm ... etc. (cut leads only available in bulk pack)

A = Taped & Ammo pack, R = Taped & on Reel

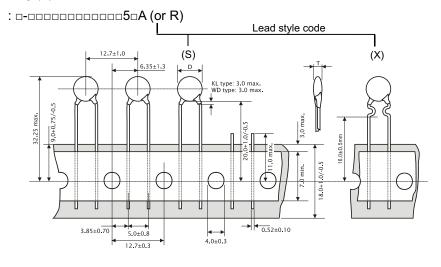
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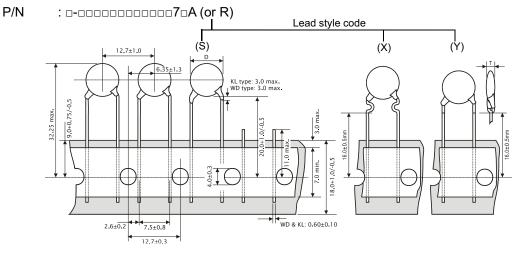
TAPING SPECIFICATION

P/N

Lead spacing (F): 5mm

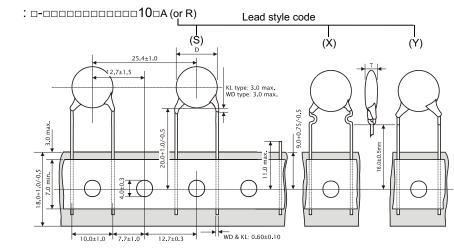


Lead spacing (F): 7.5mm



Lead spacing (F): 10.0mm

P/N



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SPECIFICATION AND TEST METHOD

- 1. Please measure with the ambient temperature of 25±2°C, relative humidity of 45~85 percent.
- 2. Please measure in this order: Capacitance, DF, IR, Test voltage
- 3. Measurement of voltage of high-voltage capacitors should be based on 150V/µs rate, rise from 0V voltage . The test of time can be increased to test the voltage start time.

Measuring the end of the capacitor should discharge.

No.	lte	em		Specification		Те	sting Meth	od	
1		ince and nsions		efect on appearance form ns are within specified range.		acitor should be v ons should be me		d for evidence of defect. e calipers.	
2	Mar	king	To be easily le	egible		The capacitor should be visually inspected			
3	Capacita	nce (CR)	Within specifie	ed tolerance					
4	Dissipation Factor (tan δ) or Q Value		Char. C, S X, B, E F	Specification Q ≥ 400+20CR (CR < 30pF)		d be measured at 2MHz) and			
5	5 Insulation Resistance (I.R.)		10,000MΩ mi	n.	The insulation resistance should be measure with DC500: within 60±5 sec. of charging. The voltage should be applie the capacitor through a resistor of 1MΩ.				
6	Dielectric Strength	Between Lead Wires Body Insulation	No failure No failure		First, the connecte at right, i wrapped to the dis from eac Then, th inserted metal ba Finally, <i>A</i> applied f	acitor should not l are applied betwe (Discharge current Type Test Voltage eterminals of the order dogether. Then a metal foil should around the body stance of about 3 or terminal. e capacitor should into a container fi Ils of about 1mm AC voltage of Tab or 60 sec. betwee r lead wires and r Type Test Voltage	<pre>en the lead wire tt =50mA) </pre> Table 1 > KL AC2500V capacitor should t, as shown in fig the capacitor to 4mm d be closely of the capacitor to 4mm d be illed with diameter. le 2 is en the	WD AC4000V	
7		erature teristics	Char. C S	Capacitance Change Within ± 10% Within ± 15% Within +20% / -55% Within +30% / -80% op range: -25 to +85°C) Temperature Coefficient 0±30ppm/°C +350 to -1000ppm/°C op range: -25 to +85°C)		acitance measure l in Table 3. Step 1 2 3 4 5	<pre>ement should be < Table 3 > Temperatu 20 ± : -25 ± 20 ± : 85 ± : 20 ± : </pre>	2 2 2 2 2	

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continue ...



No.	lte	m		Specification	Testing Method				
8	Solder of Le		coating on t	hould be soldered with uniform the axial direction over 3/4 of the tial direction.	The lead wire of a capacitor should be dipped into molten solder for 2±0.5 sec. The depth of immersion is up to about 1.5 to 2.0mm from the root of lead wires. Temp. of solder: Lead Free Solder (Sn-3Ag-0.5Cu) 245±5°C H63 Eutectic Solder (Pb37/Sn63) 235±5°C				
		Appearance	No marked	defect	The lead wires should be immersed in				
9	Soldering Effect	Capacitance change	C, S: ±5% c B: ±10% X, E, F: ±20	or 1pF, whichever is larger %	1.5mm to 2.0mm from the root of terminal for 3.5±0.5 sec. (10±1 sec for 260±5°C)				
5	(Non-Preheat)	I.R.	1,000MΩ m	in	Pre-treatment: Capacitor should be stored at 85±2°C for 1hr., and then placed at room condition for 24±2 hrs. before initial meaurements.				
		Dielectric Strength	Per Item 6		Post-treatment: Capacitor should be stored for 1 to 2 hrs. at room condition.				
		Appearance	No marked	defect					
10	Soldering Effect	Capacitance change	C, S: ±5% c B: ±10% X, E, F: ±20	or 1pF, whichever is larger %	Capacitor should be stored at 120+0/-5°C for 60+0/-5 sec. The lead wires should be immersed in solder of 260±5°C up to 1.5mm to 2.0mm from the root of terminal for 7.5+0/-1 sec.				
	(On-Preheat)	I.R.	1,000MΩ m	in	Pre-treatment and Post-treatment: see per Item 9				
		Dielectric Strength	Per Item 6						
		Appearance	No marked	defect	The capacitor should be firmly soldered to the supporting lead wire and vibrated at a frequency range of 10Hz to 55Hz,1.5mm				
11	Vibration Resistance	Capacitance	Within the s	pecified tolerance	in total amplitude, with about a 1 minute rate of vibration change from 10Hz to 55 Hz and back to 10Hz. Apply for a total of 6 hrs.,				
		tan δ or Q	Per Item 4		2 hrs each in 3 mutually perpendicular directions.				
		Appearance	No marked defect		-				
		Capacitance change	C: Within ±2 S: Within ±5 X, B, E: Wit F: Within ±1	5% hin ±10%					
12	Humidity (Under Steady State)	tan δ or Q	Char. C, S	$\begin{tabular}{lllllllllllllllllllllllllllllllllll$	Set the capacitor for 500±12 hrs., at 40±2°C in 90 to 95% relative humidity. Post-treatment:				
			X, B, E	tan δ: 0.050 max.	Capacitor should be stored for 1 to 2 hrs. at room condition.				
			F	tan δ: 0.075 max.	-				
		I.R. Dielectric Strength	3,000MΩ m Per Item 6	in					
		Appearance	No marked	defect					
		Capacitance change	C: Within ±2 S: Within ±5 X, B, E: Wit F: Within±1	5% hin ±10%					
	L la une l'allée a		Char.	Specification	Apply the rated voltage for 500±12 hrs. at 40±2°C in 90 to 95% relative humidity.				
13	Humidity Loading	tan δ or Q	C, S	$Q \ge 275+5/2C_R (C_R < 30pF)$ $Q \ge 350 (C_R \ge 30pF)$	Post-treatment:				
			X, B, E	tan δ: 0.050 max.	Capacitor should be stored for 1 to 2 hrs. at room condition.				
			F	tan δ: 0.075 max.					
		I.R.	3,000MΩ m	in	4				
		Dielectric Strength	Per Item 6						

continue ...

SPECIFICATION AND TEST METHOD (continue ...)

INTERNATIONAL

No.	lte	em	Specification	Testing Method				
		Appearance Capacitance change	No marked defect C: Within ±2.5% S: Within ±5% X, B, E: Within ±10% F: Within±15%	Impulse Voltage: Each individual capacitor should be subjected to a 5kV (Type X1Y1: 8kV) impulses for three times. After the capacitors are applied to life test.				
14	Life Test	I.R. Dielectric Strength	3000MΩ min Per Item 6	Apply a voltage of Table 4 for 1000 hrs. at 125+2/-0°C, and relative Humidity of 50% max. Table 4 > Applied Voltage AC425V (r.m.s.), except that once each hour the Voltage is increased to AC1000V (r.m.s.) for 0.1 sec.				
15	Flame	e Test	The capacitor flame discontinues as follows.CycleTime (sec.)1 to 430560	Capacitor should be stored for 1 to 2 hrs. at room condition The capacitor should be subjected to applied flame for 15 sec. And then removed for 15 sec. until 5 cycles are completed.				
16	Robustness of Terminations		Lead wire should not be cut off. Capacitor should not be broken.	Fix the body of the capacitor and apply a tensile weight gradually to each lead wire in the radial direction of the capacitor up to 10N and keep it for 10±1 sec. Each lead wire should be subjected to 5N weight and then a 90° bend, at the point of egress, in one direction, return to original				
17	Active Fla	Bending	The cheese-cloth should not be on fire	position, and then apply a 90° bend in the opposite direction at the rate of one bend in 2 to 3 sec. The capacitor should be individually wrapped in at least one but not more than two complete layers of cheese-cloth. The capacitor should not be subjected to 20 discharges. The interval between successive discharges should be 5 sec. The UAC should be maintained for 2 minutes after the last discharge. trial to the trial to the tr				
18	Passive FI	ammability	The burning time should not exceed 30 sec. The tissue paper should not ignite.	The capacitor under test should be held in the flame in the position which best promotes burning. Each specimen should only be exposed once to the flame. Time of exposure to flame : 30 sec.				

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continue ...

SPECIFICATION AND TEST METHOD (continue ...)

No.	lte	m Specification			Testing Method					
		Appearance	No marked defect		capacitor should be subjected to 5 temperature cycles, then ecutively to 2 immersion cycles. < Temperature Cycle >					
					Step	Temperatu		Time (min)		
			C: Within ±2.5%		1	-25+0/	-3	30		
		Capacitance change	S: Within ±5% X, B, E: Within ±10%		2 Room temperature		3			
		g-	F: Within ±15%	3 125+3/-0		30				
					4	Room temp	erature	3		
19	Temperature and Immersion Cycle	tan δ or Q	Per Item 4		Step	Temperature	C nersion Cycle Time	Immersion		
					•	(°C)	(min)	Water		
		I.R.	3,000MΩ min		1 2	65+5/-0 15	0±3 15	Clean water Salt water		
							C	Cycle time : 2 cycle		
		Dielectric Strength	Por Itom 6		 Pre-treatment: Capacitor should be stored at 85±2°C for 1hr., and then placed at room condition for 24±2 hrs. before initial meaurements. Post-treatment: Capacitor should be stored for 24±2 hrs. at room condition. 					

STORAGE ENVIRONMENT

Do not use or store capacitors in a corrosive atmosphere, especially where chloride gas, sulfide gas, acid, alkali, salt or the like are present. And avoid exposure to moisture. Store the capacitors where the temperature and relative humidity do not exceed 5 to 40 degree centigrade and 20 to 70%.